

APPENDIX D: SYSTEM CERTIFICATE & CALIBRATION

D1: SAM PHANTOM

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 1 245 9700, Fax +41 1 245 9779 info@speag.com, http://www.speag.com

Certificate of Conformity / First Article Inspection

Item	Oval Flat Phantom ELI 4.0	
Type No	QD OVA 001 B	
Series No	1003 and higher	
Manufacturer	SPEAG	
	Zeughausstrasse 43	
	CH-8004 Zürich	
	Switzerland	

Tests

Complete tests were made on the prototype units QD OVA 001 AA 1001, QD OVA 001 AB 1002, pre-series units QD OVA 001 BA 1003-1005 as well as on the series units QD OVA 001 BB, 1006 ff.

Test	Requirement	Details	Units tested
Dimensions	Compliant with the standard IEC 62209 – 2 [1] requirements	Dimensions of bottom for 300 MHz – 6 GHz: longitudinal = 600 mm (max. dimension) width= 400 mm (min dimension) depth= 190 mm Shape: ellipse	Prototypes, Samples
Material thickness	Compliant with the standard IEC 62209 – 2 [1] requirements	Bottom plate: 2.0mm +/- 0.2mm	Prototypes, All items
Material parameters	Dielectric parameters for required frequencies	300 MHz – 6 GHz Rel. permittivity = 4 +/-1, Loss tangent ≤ 0.05	Material sample
Material resistivity	The material has been tested to be compatible with the liquids defined in the standards if handled and cleaned according to the instructions. Observe Technical Note for material compatibility.	DEGMBE based simulating liquids	Equivalent phantoms, Material sample
Sagging	Compliant with the requirements according to the standard. Sagging of the flat section when filled with tissue simulating liquid	< 1% typical < 0.8% if filled with 155mm of HSL900 and without DUT below	Prototypes, Sample testing

Standards

[1] IEC 62209 - 2, Draft Version 0.9, "Evaluation of Human Exposure to Radio Frequency Fields from Handheld and Body-Mounted Wireless Communication Devices in the Frequency Range of 30 MHz to 6 GHz: Human models, Instrumentation and Procedures

Part 2: Procedure to determine the Specific Absorption Rate (SAR) for ... including accessories and multiple transmitters", December 2004

Conformity

Based on the sample tests above, we certify that this item is in compliance with the standard [1].

Date

07.07.2005

Schmill & Parther Engineering AG Zeughas Astrasse 43, 8004 Zurich Switzerf Phone 41 1-245-3200 Fex 4412 245 278

e

Signature / Stamp

info@speag.com, http://www.speag.com

a



D2: DOSIMETRIC E-FIELD PROBE

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

BV-ADT (Auden)

Accreditation No.: SCS 108

Certificate No: EX3-3590_Mar10

CALIBRATION CERTIFICATE

Object EX3DV4 - SN:3590

Calibration procedure(s) QA CAL-01.v6, QA CAL-14.v3, QA CAL-23.v3 and QA CAL-25.v2

Calibration procedure for dosimetric E-field probes

Calibration date: March 25, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41498087	1-Apr-09 (No. 217-01030)	Apr-10
Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 660	29-Sep-09 (No. DAE4-660_Sep09)	Sep-10
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct10
	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	RH
		X	
Approved by:	Niels Kuster	Quality Manager	1605
			V. 1

Issued: March 25, 2010

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Glossary:

TSL NORMx,y,z tissue simulating liquid sensitivity in free space sensitivity in TSL / NORMx,y,z

ConvF DCP

diode compression point

CF A, B, C crest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters

Polarization φ

φ rotation around probe axis

Polarization 9

9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., $\theta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

 a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003

b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
 NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

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Probe EX3DV4

SN:3590

Manufactured:

Last calibrated: Recalibrated:

March 23, 2009

April 28, 2009

March 25, 2010

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: EX3-3590_Mar10

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DASY - Parameters of Probe: EX3DV4 SN:3590

Basic Calibration Parameters

		Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)^A$	0.49	0.49	0.50	± 10.1%
DCP (mV) ^B	88.1	87.5	87 <i>.</i> 6	

Modulation Calibration Parameters

UID	Communication System Name	PAR	,	A dB	B dBuV	С	VR mV	Unc ^E (k=2)
10000	cw	0.00	Х	0.00	0.00	1.00	300	± 1.5%
	And the second s		Υ	0.00	0.00	1.00	300	
			Z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^{*} The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

⁸ Numerical linearization parameter: uncertainty not required.

E Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

March 25, 2010

DASY - Parameters of Probe: EX3DV4 SN:3590

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	10.25	10.25	10.25	0.74	0.61 ± 11.0%
1750	± 50 / ± 100	40.1 ± 5%	1.37 ± 5%	8.89	8.89	8.89	0.76	0.58 ± 11.0%
1950	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	8.33	8.33	8.33	0.62	0.64 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	7.90	7.90	7.90	0.36	0.84 ± 11.0%
2600	± 50 / ± 100	39.0 ± 5%	1.96 ± 5%	7.79	7.79	7.79	0.19	1.32 ± 11.0%
5200	± 50 / ± 100	36.0 ± 5%	4.66 ± 5%	5.30	5.30	5.30	0.40	1.90 ± 13.1%
5300	± 50 / ± 100	35.9 ± 5%	4.76 ± 5%	4.92	4.92	4.92	0.45	1.90 ± 13.1%
5500	± 50 / ± 100	35.6 ± 5%	4.96 ± 5%	4.93	4.93	4.93	0.45	1.90 ± 13.1%
5600	± 50 / ± 100	35.5 ± 5%	5.07 ± 5%	4.63	4.63	4.63	0.50	1.90 ± 13.1%
5800	± 50 / ± 100	35.3 ± 5%	5.27 ± 5%	4.54	4.54	4.54	0.50	1.90 ± 13.1%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

DASY - Parameters of Probe: EX3DV4 SN:3590

Calibration Parameter Determined in Body Tissue Simulating Media

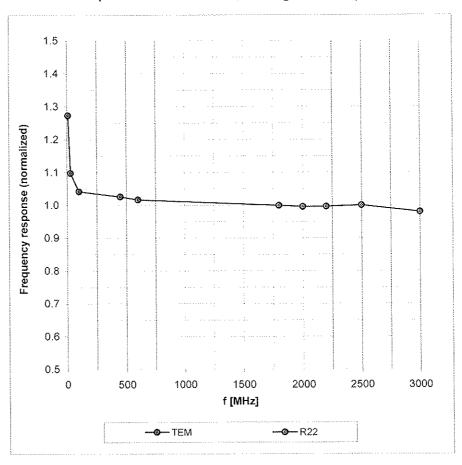
f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X C	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	10.20	10.20	10.20	0.60	0.71 ± 11.0%
1750	± 50 / ± 100	53.4 ± 5%	1.49 ± 5%	8.69	8.69	8.69	0.79	0.58 ± 11.0%
1950	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	8.61	8.61	8.61	0.40	0.80 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	8.20	8.20	8.20	0.28	1.02 ± 11.0%
2600	± 50 / ± 100	52.5 ± 5%	2.16 ± 5%	8.04	8.04	8.04	0.21	1.25 ± 11.0%
5200	± 50 / ± 100	49.0 ± 5%	5.30 ± 5%	4.80	4.80	4.80	0.53	1.95 ± 13.1%
5300	± 50 / ± 100	48.5 ± 5%	5.42 ± 5%	4.50	4.50	4.50	0.53	1.95 ± 13.1%
5500	± 50 / ± 100	48.6 ± 5%	5.65 ± 5%	4.32	4.32	4.32	0.55	1.95 ± 13.1%
5600	± 50 / ± 100	48.5 ± 5%	5.77 ± 5%	4.16	4.16	4.16	0.50	1.95 ± 13.1%
5800	± 50 / ± 100	48.2 ± 5%	6.00 ± 5%	4.41	4.41	4.41	0.60	1.95 ± 13.1%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

March 25, 2010

Frequency Response of E-Field

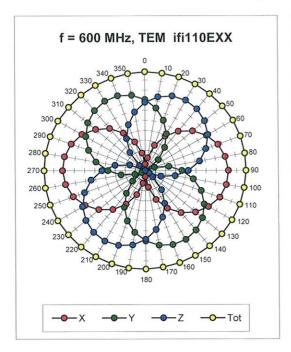
(TEM-Cell:ifi110 EXX, Waveguide: R22)

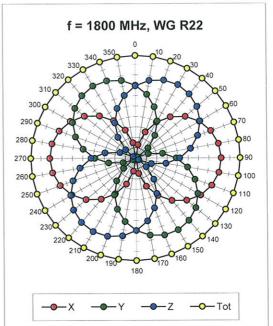


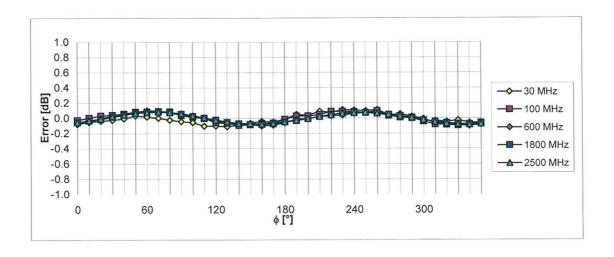
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

March 25, 2010

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



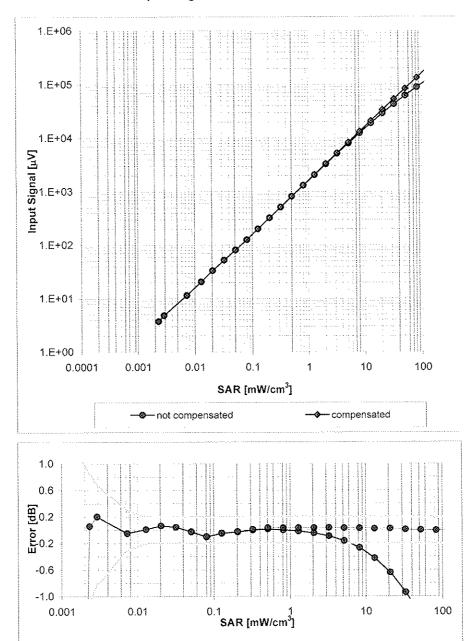




Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Dynamic Range f(SAR_{head})

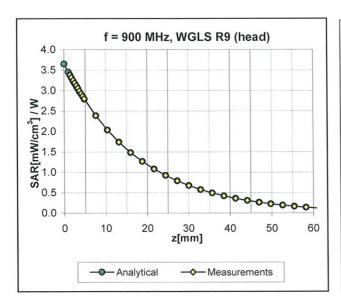
(Waveguide R22, f = 1800 MHz)

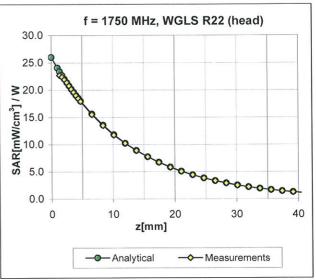


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

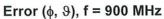
March 25, 2010

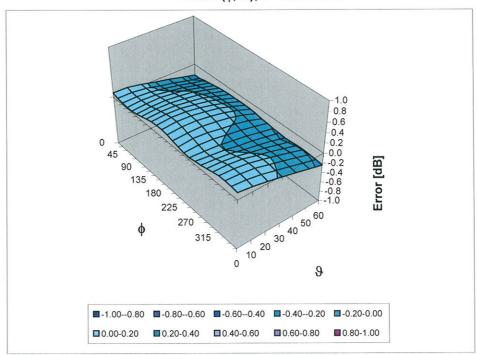
Conversion Factor Assessment





Deviation from Isotropy in HSL





Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm



D3: DAE

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IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

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Client

BV - ADT (Auden)

Accreditation No.: SCS 108

Certificate No: DAE4-861_Jan10

CALIBRATION CE			

Object

DAE4 - SD 000 D04 BJ - SN: 861

Calibration procedure(s)

QA CAL-06.v12

Calibration procedure for the data acquisition electronics (DAE)

Calibration date:

January 22, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 \pm 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	1-Oct-09 (No: 9055)	Oct-10
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	05-Jun-09 (in house check)	In house check: Jun-10

Calibrated by:

Name

Function

Andrea Guntli

Technician

Approved by:

Fin Bomholt

R&D Director

iv Bluer

Issued: January 22, 2010

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Certificate No: DAE4-861 Jan10

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Glossary

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-861_Jan10

DC Voltage Measurement A/D - Converter Resolution nominal

High Range:

1LSB =

6.1μV ,

full range = -100...+300 mV

Low Range:

1LSB =

61nV,

full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.395 ± 0.1% (k=2)	404.784 ± 0.1% (k=2)	405.737 ± 0.1% (k=2)
Low Range	4.01182 ± 0.7% (k=2)	3.98893 ± 0.7% (k=2)	4.01269 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	123.0 ° ± 1 °
b	

Appendix

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	200003.4	-2.33	-0.00
Channel X	+ Input	19997.73	-1.97	-0.01
Channel X	- Input	-19999.33	1.07	-0.01
Channel Y	+ Input	200002.5	-2.16	-0.00
Channel Y	+ Input	19995.17	-4.43	-0.02
Channel Y	- Input	-20000.88	-0.58	0.00
Channel Z	+ Input	199999.9	-3.99	-0.00
Channel Z	+ Input	19995.97	-3.43	-0.02
Channel Z	- Input	-20002.39	0.01	0.01

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	1999.9	-0.34	-0.02
Channel X	+ Input	199.26	-0.64	-0.32
Channel X	- Input	-200.72	-0.82	0.41
Channel Y	+ Input	1999.2	-0.72	-0.04
Channel Y	+ Input	198.82	-1.18	-0.59
Channel Y	- Input	-201.63	-1.83	0.92
Channel Z	+ Input	2001.1	1.22	0.06
Channel Z	+ Input	197.99	-2.01	-1.01
Channel Z	- Input	-201.59	-1.79	0.89

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.69	4.19
	- 200	-2.41	-3.99
Channel Y	200	1.24	1.40
	- 200	-2.43	-2.38
Channel Z	200	-9.16	-9.25
	- 200	8.58	8.07

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.32	1.39
Channel Y	200	1.89	-	4.20
Channel Z	200	1.32	0.19	

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15980	16853
Channel Y	16068	14547
Channel Z	16038	17866

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input $10M\Omega$

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.16	-1.64	1.60	0.66
Channel Y	-0.58	-2.29	0.44	0.49
Channel Z	-1.24	-3.18	0.50	0.68

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	199.8
Channel Y	0.2000	201.8
Channel Z	0.1999	199.7

8. Low Battery Alarm Voltage (verified during pre-test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9